## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SHELEST ET AL. | Examiner | Art Unit | Page 1 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,511,122 A	04-1996	Atkinson, Randall .	713/153
*	В	US-5,835,726 A	11-1998	Shwed et al.	709/229
*	O	US-5,983,350 A	11-1999	Minear et al.	726/11
*	D	US-6,009,475 A	12-1999	Shrader, Theodore Jack London	709/249
*	ш	US-6,141,755 A	10-2000	Dowd et al.	726/11
*	F	US-6,230,271 B1	05-2001	Wadlow et al.	726/1
*	G	US-6,317,838 B1	11-2001	Baize, Eric	726/11
*	Ξ	US-6,332,192 B1	12-2001	Boroditsky et al.	713/168
*	-	US-6,327,659 B1	12-2001	Boroditsky et al.	713/182
*	7	US-2002/0023220 A1	02-2002	Kaplan, Jonathan C.	713/176
*	К	US-2002/0161884 A1	10-2002	Munger et al.	709/224
*	L	US-2002/0199007 A1	12-2002	Clayton et al.	709/230
*	М	US-6,496,935 B1	12-2002	Fink et al.	726/13

### **FOREIGN PATENT DOCUMENTS**

*	:	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	z					
	0					
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### **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SHELEST ET AL. | Examiner | Art Unit | Page 2 of 3

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0046587 A1	03-2003	Bheemarasetti et al.	713/201
*	В	US-2003/0046391 A1	03-2003	Moreh et al.	709/225
*	С	US-2003/0046586 A1	03-2003	Bheemarasetti et al.	713/201
*	D	US-2003/0177390 A1	09-2003	Radhakrishnan, Rakesh	713/201
*	Е	US-6,615,358 B1	09-2003	Dowd et al.	726/14
*	F	US-2003/0200321 A1	10-2003	Chen et al.	709/229
*	G	US-6,631,435 B1	10-2003	Lym et al.	710/305
*	Н	US-2004/0003116 A1	01-2004	Munger et al.	709/245
*	ı	US-2004/0083394 A1	04-2004	Brebner et al.	713/202
*	J	US-6,834,795 B1	12-2004	Rasmussen et al.	235/380
*	K	US-6,883,095 B2	04-2005	Sandhu et al.	713/168
*	L	US-6,938,157 B2	08-2005	Kaplan, Jonathan C.	713/176
*	М	US-6,931,529 B2	08-2005	Kunzinger, Charles A.	713/153

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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### **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited Application/Control No. 10/611,832 Examiner David G. Cervetti Applicant(s)/Patent Under Reexamination SHELEST ET AL. Page 3 of 3

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,954,862 B2	10-2005	Serpa, Michael Lawrence	726/5
*	В	US-7,020,645 B2	03-2006	Bisbee et al.	707/1
*	С	US-7,010,604 B1	03-2006	Munger et al.	709/227
*	D	US-7,051,365 B1	05-2006	Bellovin, Steven Michael	726/11
*	E	US-7,058,817 B1	06-2006	Ellmore, Kimberly	713/183
*	F	US-7,073,067 B2	07-2006	Mizrah, Len L.	713/183
*	G	US-7,143,174 B2	11-2006	Miller et al.	709/228
*	Ξ	US-7,155,614 B2	12-2006	Ellmore, Kimberly	713/183
*	1	US-7,188,314 B2	03-2007	Mizrah, Len L.	715/741
	J	US-			
	К	US-			
	L	US-			
	М	US-			

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.